Lucarelli et al. reply to Tajim a et al.

In their Comment on our paper,[1] Tajim a et al. [2] argue that our infrared results on nine single crystals of La $_2$ xSrxCuO $_4$ (LSCO) are not valid because:

i) Ref. [1] reports three peaks, at 30 (for x=0.12), 250, and 500 cm $^{-1}$; ii) the x=0.05 sam ple shows a dip at 470 cm $^{-1}$ due to a tranverse optical phonon of the c-axis at 500 cm $^{-1}$; therefore, the sam ple is not a single crystal or it is m iscut; iii) the sam e dip is observed m ore or less in all sam ples, except for those w ith x=0.0 and 0.26; therefore, all sam ples are bad crystals, are m iscut, or the polarizer was not e ective; iv) as most sam ples contain the c-axis, also the peak at 30 cm $^{-1}$ is a spurious feature; v) the previous observations on the sam e system do not show the peaks we report in Ref. [1].

D etails on the sam ples and experiments w ill be given in a forthcoming paper. [3] Here, we reply to each of the above points.

i) In all the superconducting crystals investigated in Ref. [1], strong peaks are observed below 150 cm $^{\rm 1}$, which depend on temperature and doping consistently with a charge stripe scenario (Figs. 2 and 3 of Ref. [1]). The strong conductivity peak at 250 cm $^{\rm 1}$ and the weak peak at 500 cm $^{\rm 1}$ are discussed only for the semiconducting 0.05 sample, in connection with Thomas et al. who observed very similar features in a ux-grown La₂SrCuO $_{\rm 4+y}$ crystal where the surface is intrinsically a b.[4]

ii) The x = 0.05 sam ple arrived already cut. We veried that it is an excellent single crystal by X-ray measurements at the Walther-Meissner Institut of Garching (Germany).

iii) This is a crucial point, as it questions the peaks below 150 cm⁻¹. We are surprised by this comment. Fig. 1 shows the rejectivity R (!) for our x = 0.12 sample and for an x = 0.13 LSCO crystal from a paper co-authored by one (D.N.B.) of the authors of the Comment.[5] Both samples show a dip at 470 cm⁻¹ for electric eld orthogonal to the caxis. In Ref. 5, the 0.13 sample is described as follows: "The miscut angle between the polished surface and the caxis was checked by a high precision triple axis X-ray di ractom eter and was determ ined to be less than 0.8° ". Therefore, in no way the presence of the dip at 470 cm⁻¹ can be used as evidence for a miscut of the crystal. This feature has been observed, indeed, in ux-grown La₂CuO_{4+v},[6] in well-cut (error less than 1^0) LSCO [7] and, with minor changes, in many other cuprates where it has been explained in a non-trivialway.[8]

iv) In Fig. 1 one sees also that the low-frequency side of the a b plane R (!), where the strong peaks appear, is not a ected by the c-axis re ectivity. The same holds for the other samples. [3] Incidentally, in the x = 0.15

spectrum,[1] strong far-infrared peaks spring up at low T while the dip at 470 cm $^{-1}$ is very weak at any T .

v) The authors of Ref. [2] support their argument by citing three papers. Two of them report data on thin lms, known to be a ected by the subtraction of the sub-

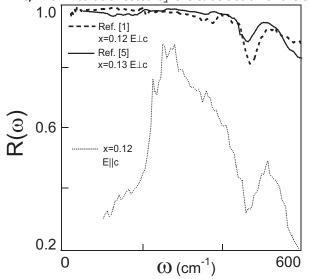


FIG. 1: Re ectivity for eld orthogonal to the caxis for our sample with x=0.12 at 30 K and for a sample with x=0.13 at 10 K from Ref. [5]. In the latter crystal the miscut was less than 0.8° . A test of R (!) along cat 295 K for the same x=0.12 sample is also shown.

strate contribution, the third one reports measurements at grazing incidence. When measuring at quasi-normal incidence single LSCO crystals, anomalous peaks are observed instead, similar to those in Ref. [1]: see, therein, Refs. [16],[21],[22], and a recent preprint as well.[9] Concerning the paper of Dummetal,[10] the remark in Ref. [2] does not report faithfully the note we added to Ref. [1].

In conclusion, the high quality and good orientation of the crystals measured in Ref. [1] is not questioned by the presence of a dip in R (!) at 470 cm $\,^{1}$. The latter feature appears both in well-cut crystals grown by the oatingzone method and in ux-grown samples. Our case on a charge-stripe scenario for LSCO is supported by a sound trend of the optical conductivity throughout its phase diagram and fully agrees with the results of Raman [11] and neutron [12] spectroscopy on samples from the same laboratories.

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